

Notice of References Cited

Application/Control No.

10/523,990

Applicant(s)/Patent Under
Reexamination
HAYAISHI ET AL.

Examiner

Jie Yang

Art Unit

1709

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,764,645	07-2004	Hayaishi et al.	420/125
*	B	US-6,783,728	08-2004	Kano et al.	420/84
*	C	US-6,773,661	08-2004	Hayaishi et al.	420/87
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	N	JP 11350065 A	12-1999	Japan	INOUE et al.	
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NON-PATENT DOCUMENTS

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	U	Machine translation of JP-11-350065
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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